



6/23/2009

**PRODUCT RELIABILITY REPORT
FOR**

DS2505, Rev C2

Maxim Integrated Products

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Prepared by:

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Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim products:

DS2505, Rev C2

In addition, Maxim's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at <http://www.maxim-ic.com/TechSupport/dsreliability.html>.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l_datasheet3.cfm.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

$$AfT = \exp((Ea/k) * (1/Tu - 1/Ts)) = tu/ts$$

AfT = Acceleration factor due to Temperature
tu = Time at use temperature (e.g. 55°C)
ts = Time at stress temperature (e.g. 125°C)
k = Boltzmann's Constant (8.617 x 10⁻⁵ eV/°K)
Tu = Temperature at Use (°K)
Ts = Temperature at Stress (°K)
Ea = Activation Energy (e.g. 0.7 ev)

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

$$AfV = \exp(B * (Vs - Vu))$$

AfV = Acceleration factor due to Voltage
Vs = Stress Voltage (e.g. 7.0 volts)
Vu = Maximum Operating Voltage (e.g. 5.5 volts)
B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

$$Fr = X / (ts * AfV * AfT * N * 2)$$

X = Chi-Sq statistical upper limit
N = Life test sample size

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

$$MTTF = 1/Fr$$

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE: **MTTF (YRS):** **71677** **FITS:** **1.6**
DEVICE HOURS: **575331940** **FAILS:** **0**

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% **Ea: 0.7** **B: 0** **Tu: 25 °C** **Vu: 5.5 Volts**

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

Device Information:

Process: SA E6ES-2P1M,HPVt,EPROM,NRDSD,ESD-PD,N+ESD, ALOCOS.
 Passivation: Pass w/Nov.TEOS Oxide-OxyNit (NO REGLASS)
 Die Size: 92 x 58
 Number of Transistors: 6100
 Interconnect: Aluminum / 0.5% Copper
 Gate Oxide Thickness: 150 Å

DATA RETENTION

DESCRIPTION	DATE	CODE/PRODUCT/LOT	CONDITION	READPOIN	QTY	FAILS	FA#
STORAGE LIFE	0832	DS2505	WH941772A 150C	1000 HRS	77	0	
STORAGE LIFE	0837	DS2505	WH942720A 150C	1000 HRS	77	0	
STORAGE LIFE	0838	DS2505	WH941773A 150C	1000 HRS	77	0	
Total:						0	

ELECTRICAL CHARACTERIZATION

DESCRIPTION	DATE	CODE/PRODUCT/LOT	CONDITION	READPOIN	QTY	FAILS	FA#
ESD SENSITIVITY	0832	DS2505	WH941772A EOS/ESD S5.1 HBM 500 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A EOS/ESD S5.1 HBM 1000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A EOS/ESD S5.1 HBM 2000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A EOS/ESD S5.1 HBM 4000 VOLTS	1 PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A EOS/ESD S5.1 HBM 8000 VOLTS	1 PUL'S	3	0	

ESD SENSITIVITY	0832	DS2505	WH941772A	IEC 61000-4-2 CONTACT 2000 VOLTS	10	PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A	IEC 61000-4-2 CONTACT 4000 VOLTS	10	PUL'S	3	0	
ESD SENSITIVITY	0832	DS2505	WH941772A	IEC 61000-4-2 CONTACT 8000 VOLTS	10	PUL'S	3	3	No FA
LATCH-UP	0832	DS2505	WH941772A	JESD78, V-SUPPLY TEST 25C			6	0	
LATCH-UP	0832	DS2505	WH941772A	JESD78, V-SUPPLY TEST 125C			6	0	
Total:								3	

ESD CDM

DESCRIPTION	DATE	CODE/PRODUCT/LOT	CONDITION	READPOIN	QTY	FAILS	FA#
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-C101 CDM 200 VOLTS	3	PUL'S	3 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-C101 CDM 500 VOLTS	3	PUL'S	3 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-C101 CDM 1000 VOLTS	3	PUL'S	3 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-C101 CDM 2000 VOLTS	3	PUL'S	3 0
Total:							0

ESD MM

DESCRIPTION	DATE	CODE/PRODUCT/LOT	CONDITION	READPOIN	QTY	FAILS	FA#
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-A115 MM 100 VOLTS	1	PUL'S	9 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-A115 MM 200 VOLTS	1	PUL'S	3 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-A115 MM 400 VOLTS	1	PUL'S	3 0
ESD SENSITIVITY	0837	DS2505	WH942720A	JESD22-A115 MM 500 VOLTS	1	PUL'S	3 0
Total:							0

OPERATING LIFE

DESCRIPTION	DATE	CODE/PRODUCT/LOT	CONDITION	READPOIN	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0727	DS2502	VH740179AD	125C, 6.0 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0832	DS2505	WH941772A	125C, 6.0 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0832	DS2502	QJ846128AB	125C, 6.0 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0837	DS2505	WH942720A	125C, 6.0 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0838	DS2505	WH941773A	125C, 6.0 VOLTS	1000 HRS	77	0
HIGH TEMP OP LIFE	0838	DS2502	VQ815408AA	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0838	DS2502	VQ815410AD	125C, 5.25 VOLTS	500 HRS	45	0
HIGH TEMP OP LIFE	0838	DS2502	VQ815410AD	125C, 5.5 VOLTS	1000 HRS	45	0
HIGH TEMP OP LIFE	0838	DS2502	VQ844524AA	125C, 5.25 VOLTS	1000 HRS	45	0

FAILURE RATE:	MTTF (YRS):	71677	FITS:	Total:	0
	DEVICE HOURS:	575331940	FAILS:	1.6	
				0	